

Ambient-Stable Two-Dimensional Titanium Carbide (MXene) Enabled by Iodine Etching

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Abstract: MXene (e.g., Ti_3C_2) represents an important class of two-dimensional (2D) materials owing to its unique metallic conductivity and tunable surface chemistry. However, the mainstream synthetic methods rely on the chemical etching of MAX powders (e.g., Ti_3AlC_2) using hazardous HF or alike, leading to MXene sheets with fluorine termination and poor ambient stability in colloidal dispersions. Here, we demonstrate a fluoride-free, iodine (I_2) assisted etching route for preparing 2D MXene ($Ti_3C_2T_x$, $T=O, OH$) with oxygen-rich terminal groups and intact lattice structure. More than 71 % of sheets are thinner than 5 nm with an average size of 1.8 μm . They present excellent thin-film conductivity of $1250 S cm^{-1}$ and great ambient stability in water for at least 2 weeks. 2D MXene sheets with abundant oxygen surface groups are excellent electrode materials for supercapacitors, delivering a high gravimetric capacitance of $293 F g^{-1}$ at a scan rate of $1 mV s^{-1}$, superior to those made from fluoride-based etchants ($< 290 F g^{-1}$ at $1 mV s^{-1}$). Our strategy provides a promising pathway for the facile and sustainable production of highly stable MXene materials.

Two-dimensional (2D) transition metal carbides, nitrides or carbonitrides (MXenes) are the latest additions to the family of 2D materials.^[1] Their general formula is written as $M_{n+1}X_nT_x$ ($n=1-3$), where M stands for transition metal (e.g., Ti, Nb, Mo, V, etc.), X is C and/or N, and T_x refers to surface terminations such as hydroxyl, oxygen or fluorine, depending on the synthetic conditions and/or the subsequent

delamination procedures. Among dozens of experimentally available MXenes, titanium carbide (Ti_3C_2) is the most popular one, and it has enabled a broad range of applications, including energy storage and conversion,^[1c,2] electromagnetic interference shielding,^[3] water purification,^[4] gas- and bio-sensors,^[5] lubricants,^[6] and catalysts,^[7] due to its metallic conductivity^[3] and tunable surface functionalities.^[8]

To date, chemical etching of Ti_3AlC_2 (a MAX phase) with fluoride-based acids or salts (such as HF, LiF/HCl) represents a straightforward approach to prepare 2D $Ti_3C_2T_x$ ($T=O, OH, F$). These classic etching agents can react selectively with Al layer and remove the resulting AlF_3 efficiently from the interlayer spacing.^[9] This is a key step for the subsequent diffusion of etchants and the complete corrosion of Al layers.^[9a,10] However, the harsh etching reactions and the dissolved oxygen gas in aqueous etchants induce extra structural defects to MXene sheets and promote their degradation into TiO_2 .^[11] Moreover, the acute toxicity of fluoride etchants impedes the sustainable upscaling production of MXene sheets. Although fluoride-free etching methods, including electrochemical anodic oxidation with NH_4Cl or HCl,^[10b,12] can tackle the safety issues, the prolonged etching reactions (> 3 hours) in aqueous solutions are detrimental to achieving high-quality MXenes. In this regard, a non-aqueous route was recently developed to etch MAX powders (e.g., Ti_3SiC_2) in $CuCl_2$ molten salts.^[8a,13] Apparently, the required high temperature (up to $750^\circ C$) sets an obstacle for the practical production and applications.

Herein, we demonstrate a novel protocol for the synthesis of fluoride-free MXene using iodine etching (IE) in anhydrous acetonitrile (CH_3CN) followed by the delamination in HCl solution. The etching reaction at $100^\circ C$ enables the formation of $Ti_3C_2I_x$, which can be further transformed into $Ti_3C_2T_x$ ($T=O, OH$) flakes (hereinafter referred as IE-MXene) with moderate sizes (ca. 1.8 μm) and high oxygen content (18.7 wt %). More than 71 % of flakes are thinner than 5 nm, and they are stable in dispersions for at least 2 weeks. Moreover, the filtrated IE-MXene film presents a high electrical conductivity ($1250 S cm^{-1}$), comparable with those prepared by fluoride etchants (e.g., $1500 S cm^{-1}$).^[14] When utilized as electrodes in a supercapacitor, such fluoride-free, oxygen-rich MXene electrodes deliver a remarkable gravimetric capacitance of $293 F g^{-1}$ at $1 mV s^{-1}$, outclassing those of reported fluoride-terminated MXenes (i.e., F-MXene, $50-290 F g^{-1}$).

Figure 1 a,b, and Figure S1 show a schematic illustration of the iodine-assisted synthetic process. MAX powders were immersed into an I_2-CH_3CN mixture where the molar ratio of $Ti_3AlC_2:I_2$ was 1:3. Given that Ti-Al bonds are more reactive

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Supporting information and the ORCID identification number(s) for the author(s) of this article can be found under:
https://doi.org/10.1002/anie.202015627.

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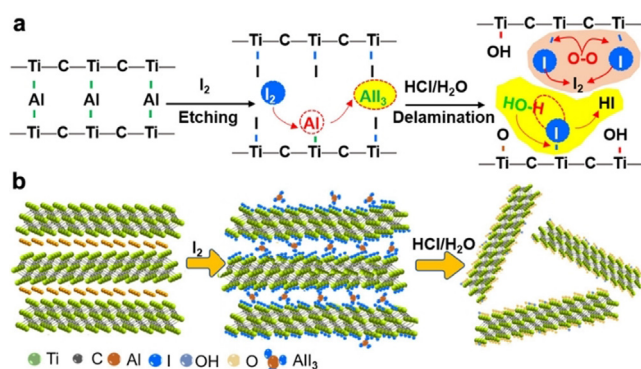


Figure 1. a,b) The iodine-assisted etching and delamination of Ti_3AlC_2 towards 2D MXene sheets.

than Ti–C bonds, iodine can remove Al layers selectively from Ti_3AlC_2 , because of its moderate redox potential ($E^\circ(\text{I}_2/\text{I}^-) = 0.54 \text{ eV}$) (Figure S2, 3). The layered etched materials were collected for further delamination. Note that, the accordion-like structure blocked a small amount of AlI_3 particles between the layers, which were difficult to wash away even after repeatedly rinsing with acetonitrile. Therefore, I_2 -etched MAX powders were transferred into a 1.0 M HCl aqueous solution to dissolve the remaining AlI_3 and delaminate multilayer MXene. We found that manual shaking in HCl solution was efficient enough to separate 2D IE-MXene sheets, and disperse them in water for further studies. Since the reaction between Al and I_2 is thermodynamically dominated,^[15] the reaction temperature plays a crucial role (Figure S4). For example, at room temperature (25°C), the etching reaction did not occur even after 2 weeks. Increasing the temperature to 60°C enabled a decreasing Al content from 16.7 wt % in the MAX phase to 2.5 wt % in the iodine-etched samples collected after the delamination in HCl. At 100°C , the residual amount of Al in such samples was greatly reduced to 0.9 wt % (Table S1).

To uncover the mechanism of etching/delamination processes, I_2 -etched MAX and 2D IE-MXene were, respectively collected and characterized. Based on the X-ray diffraction (XRD) patterns (Figure 2a), the characteristic (104) peak of Ti_3AlC_2 ($2\theta = 39^\circ$) disappears, and the (002) peak ($2\theta = 9.8^\circ$) shifts to a lower angle ($2\theta = 6.1^\circ$), indicating the expansion of interlayer spacing from 9.3 to 14.4 \AA , due to the successful Al etching. AlI_3 did not introduce additional peaks to I_2 -etched MAX due to its relatively poor crystallinity and small amount. The subsequent washing and delamination of I_2 -etched MAX in HCl solution enables further shifting of (002) peak towards an even lower angle ($2\theta = 5.2^\circ$), corresponding to an interlayer spacing of 17.4 \AA . Scanning electron microscope (SEM) images (Figure 2b–d) clearly revealed the morphological changes. Compared with the compact layered bulk Ti_3AlC_2 , I_2 -etched MAX had an obvious expansion owing to the introduction of iodide terminated groups (Figure S5), consistent with the XRD results. Energy-dispersive X-ray spectroscopy (EDS) elemental mapping was deployed to understand the changes in their chemical structures (Figure S6, 7). Five characteristic elements, including Ti, C, Al, I, and O were detected from I_2 -etched MAX, in

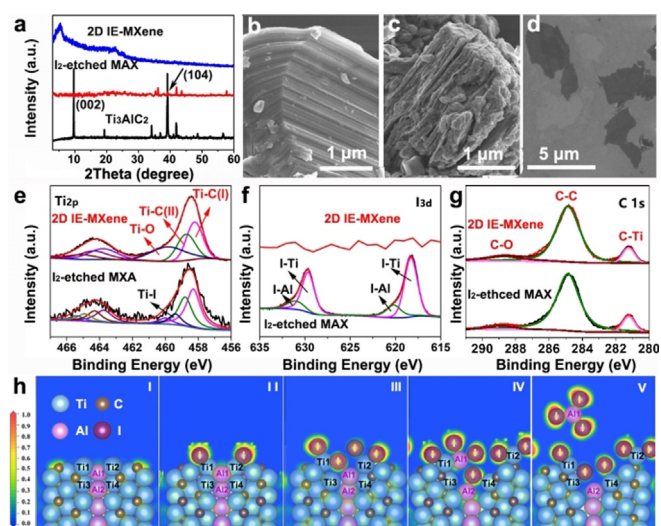
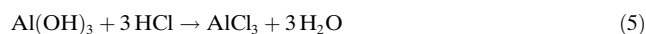
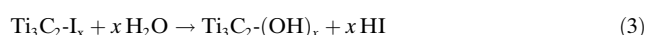
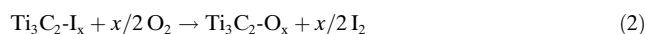
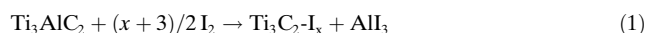


Figure 2. The etching and delamination of Ti_3AlC_2 . a) XRD patterns and SEM images of b) MAX phase, c) I_2 -etched MAX, and d) 2D IE-MXene flakes. e–g) High-resolution XPS spectra of Ti 2p, I 3d, and C 1s, respectively, in the I_2 -etched MAX and IE-MXene. h) ELF plots for the mechanism of the etching process.

which Al atoms (3.2 wt %) mainly come from residual AlI_3 in interlayer spacing. After AlI_3 was removed in the delamination process, only three main elements (Ti, C, and O) were identified from the overview EDS spectrum in 2D IE-MXene. The iodine content was negligible, but oxygen content had a visible improvement from 6.6 wt % (in the etched MAX) to 18.7 wt % (in 2D IE-MXene sheets), which is much higher than F-MXenes (10.8 wt %, Figure S8). In theory, the bond energies of Ti–I, Ti–F, and Ti–O are 310 ± 42 , 569 ± 33 , and $666.5 \pm 5.6 \text{ kJ mol}^{-1}$, respectively.^[16] Ti–I bond of $\text{Ti}_3\text{C}_2\text{I}_x$ is much weaker than Ti–F bond of F-MXenes; therefore, it undergoes spontaneous substitution reactions with water and oxygen, resulting in the replacement of I with O and OH groups.

Furthermore, we have examined the formation of AlI_3 in the etching process (Figure S9). The obvious color change from brown to dark brown in solution was observed owing to the dissolved AlI_3 . The brown powder collected from the etching solution shows two weak XRD peaks at 25.5° and 29.1° indexed to AlI_3 , which was further evidenced by ultraviolet-visible spectroscopy (UV/Vis) where the etching solution has similar absorption peaks in comparison to pure AlI_3 dissolved in acetonitrile.^[17] In addition, the overview X-ray photoelectron spectroscopy (XPS) spectrum of I_2 -etched MAX (Figure 2e–g) presents five major peaks assigned to O 1s, Ti 2p, C 1s, Al 2p, and I 3d, respectively. High resolution Ti 2p and I 3d bands confirms the presence of Ti–I bonds as surface groups. As expected, the survey spectrum of 2D IE-MXene sheets shows three major bands corresponding to O 1s, Ti 2p, C 1s, and negligible Al 2p band (Figure S10). However, no iodine group was detected in the final product, which suggested a complete substitution of iodide. The peak fitting of C 1s and Ti 2p bands reveals the presence of C–O and Ti–O bonds,^[18] resulting from the oxygen-terminated functional groups of 2D IE-MXene flakes.

According to the achieved experimental results, the mechanism of the synthetic process is proposed as below:



Reaction (1) is essential to remove Al layers from the parent Ti_3AlC_2 . Then, reactions (2) and (3) result in -O and -OH termination of 2D IE-MXene.

Density functional theory (DFT) calculation was performed to elucidate the bond breaking and reformation between I, Al, and Ti to gain a comprehensive understanding of the etching mechanism by electron localization function (ELF).^[19] As shown in Figure 2h and Figure S11, the MAX phase was modeled with stronger Ti-C (ELF = 0.8–0.9) and weaker Ti-Al bonds (ELF = 0.4–0.6). To simulate the process, I_2 molecules were introduced to the edge of the MAX phase one by one, and the Ti, Al, and C atoms at the bottom edge were fixed while all other atoms were fully relaxed (Figure S12). The etching reaction started with the dissociation of I_2 into two reactive I atoms, followed by their adsorption and integration with Ti1 and Ti2 atoms at the edge. Afterwards, the insertion of the second I_2 resulted in the spontaneous termination of both Ti1 and Ti2 atoms and sharply reduced Al-I bonds strength (ELF \approx 0.1). Then, I atoms from the third I_2 molecule bond with the Al1 atom at the edge of the positively charged Ti_3AlC_2 . The addition of a fourth I_2 led to the formation of AlI_3 (ELF = 0.7–0.8) and filled the vacancy by the termination with Ti (ELF = 0.5–0.6). Consequently, opening the grain boundaries was favorable for the further penetration of I_2 , which further weakens Ti-Al bonding and extracts Al atoms from the MAX phase.

The morphology of the 2D IE-MXene flakes was elucidated by transmission electron microscope (TEM, Figure 3a–c), and atomic force microscopy (AFM, Figure 3d). TEM image displays a typical MXene flake with a thin and flexible feature. Furthermore, the selected area electron diffraction (SAED) pattern indicates a hexagonal symmetry and high crystallinity of the MXene sheets.^[20] High-resolution TEM images (HR-TEM) collected from different positions (Figure S13) demonstrates the structural integrity of 2D IE-MXene without showing defective lattices thanks to the mild etching in non-aqueous solvents. According to AFM images collected from 132 different flakes, the thickness of most flakes (> 71%) was smaller than 5 nm (Figure 3e,f). Moreover, based on the statistical analysis of 187 individual sheets, the average lateral size of 2D IE-MXene sheets is 1.8 μm , larger than the MXenes prepared by HF etching (< 500 nm).^[4b,21] The large and thin nature of flakes made it easy to prepare MXene film by filtration of MXene dispersion. The stacked thin films exhibited a high electrical conductivity of 1250 S cm^{-1} , comparable with F-MXenes (e.g. 1500 S cm^{-1}).^[14]

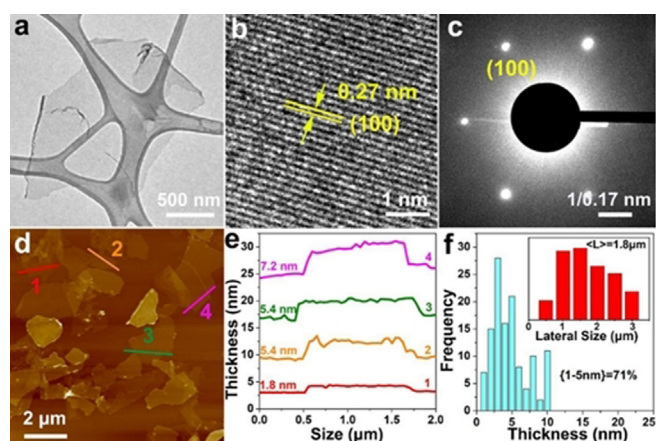


Figure 3. Structural characterization of the 2D IE-MXene flakes. a) TEM image, b) high-resolution TEM image, and c) SAED pattern. d) AFM image, e) the corresponding height profile, and f) statistical thickness distribution (inset: size distribution) of the 2D IE-MXene flakes.

Interestingly, the as-prepared fluoride-free IE-MXene exhibits an enhanced ambient stability compared with F-terminated MXenes (Table S2). According to our observation and literature work, F-terminated MXene dispersed in water presented a dramatic change in its morphology and composition and they would transform into TiO_2 nanoparticles within two weeks (Figure S14,15).^[22] By contrast, the shape and structure of IE-MXene sheets remain unchanged and well-defined under the same conditions (Figure 4, Figure S16,17). It has been concluded that the ambient stability of MXene sheets is highly relevant to the density of oxygen functional groups^[23] and structural defects.^[24] Therefore,

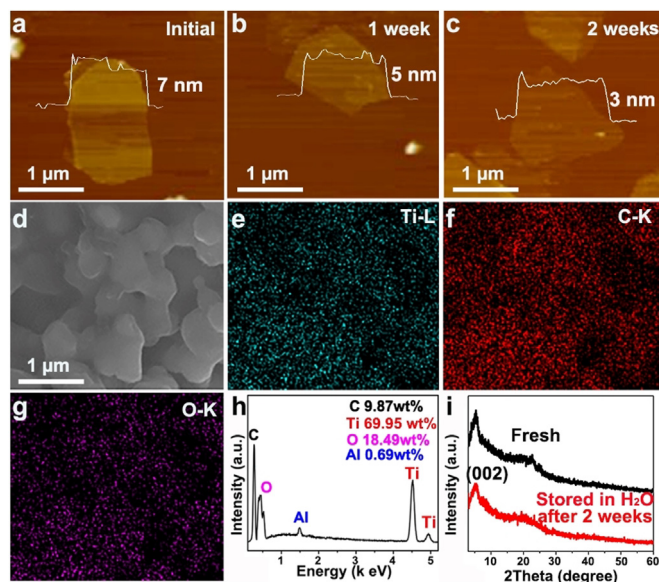


Figure 4. The ambient stability of 2D IE-MXene. a–c) AFM images of the MXene sheets after exposure in water for 1 and 2 weeks, respectively. d) SEM image and e–h) EDS elemental mapping of multiple IE-MXene sheets after keeping in water for 2 weeks. i) XRD patterns of fresh and ageing IE-MXene flakes.

the abundant oxide groups as well as crystalline structure are both helpful to extend the ambient lifetime of IE-MXene sheets.

It was reported that the oxygen-rich MXene has higher capacitance than fluoride-terminated MXenes because oxygen functional groups can act as active sites to uptake hydrogen ions in supercapacitors.^[25] Therefore, the achieved 2D IE-MXene was investigated to fabricate supercapacitors using a standard three-electrode system in the 1.0 M H₂SO₄ aqueous electrolyte. Figure 5a presented the cyclic voltammetry (CV) curves at various scan rates from 1 to 20 mV s⁻¹. The shape of CV curves was similar to F-MXene, because the capacitance mainly comes from the variation of Ti oxidation state.^[25a] The pseudocapacitive behavior was also studied through galvanostatic charge-discharge (GCD) measurements between -0.6 and 0.2 V (vs. Ag/AgCl) at current densities from 0.4 to 8 A g⁻¹ (Figure 5b). It reveals a typical pseudocapacitive character according to the GCD curves.^[26] Remarkably, the gravimetric capacitances calculated from the CV curves is 293 F g⁻¹ at a scan rate of 1 mV s⁻¹ (Figure 5c). This value is superior to previously reported F-MXene materials, which are generally lower than 290 F g⁻¹ at 1 mV s⁻¹ (Table S3). The great electrochemical performance of IE-MXene is attributable to the abundant oxygen-rich surface groups (i.e., O and OH).^[14,27] Based on the repeating GCD test at 4 A g⁻¹, the MXene electrode demonstrates an excellent cycling stability with 95.8% capacitance retention after 10000 cycles (Figure 5d), which is well comparable with the previously reported MXene-based electrode materials (Table S3). We also performed the CV scanning of the electrodes after keeping them in water for one and two weeks (Figure S18). No apparent changes in the capacitance were observed even after 2 weeks, further highlighting the excellent ambient stability of IE-MXene.

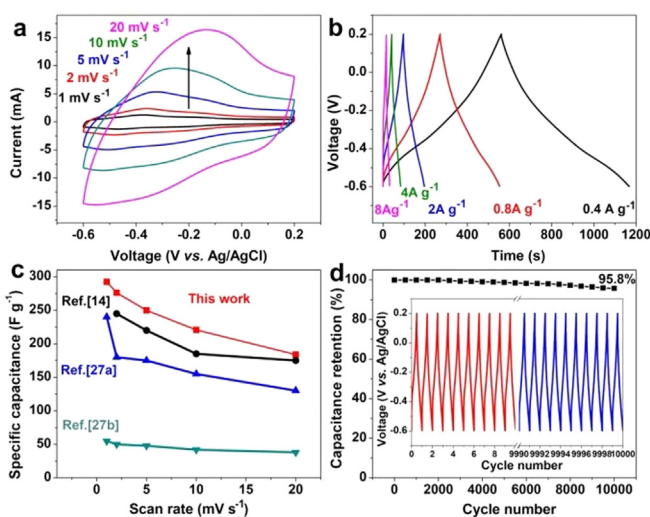


Figure 5. Electrochemical performance of 2D IE-MXene electrodes including a) CV curves at scan rates of 1–20 mV s⁻¹, b) GCD curves at current densities of 0.4–8 A g⁻¹, c) Gravimetric capacitances calculated from CV curves as a function of scan rates and d) Cycling stability at a current density of 4 A g⁻¹ (Inset shows the first and last ten GCD curves).

In conclusion, we have developed a novel iodine assisted etching strategy towards 2D fluoride-free MXene Ti₃C₂T_x (T=O, OH). The complete removal of Al layer from Ti₃AlC₂ enables a facile delamination of I₂-etched MAX in HCl solution, leading to oxygen-rich MXene sheets with high yield (71%), large size (1.8 μm), and ultimate thickness (<5 nm). Thanks to the non-aqueous etching process, 2D IE-MXene sheets exhibit high structural integrity, and they are stable in water for at least 2 weeks, superior to fluoride-terminated MXenes made from classic etching techniques. The exfoliated IE-MXene sheets with abundant oxygen surface groups allow for the fabrication of supercapacitors with high gravimetric capacitances of 293 F g⁻¹ and excellent cycling stability, surpassing most of previously reported MXene materials. Our etching strategy is promising for the future development of other types of MXenes.

Acknowledgements

This work was financially supported by Deutsche Forschungsgemeinschaft (MX-OSMOPED project), ERC Consolidator Grant on T2DCP, M-ERA-NET project HYSUCAP, SPES3 project funded by German Ministry for Education and Research (BMBF) under Forschung für neue Mikroelektronik (ForMikro) program and GrapheneCore3 881603. The authors thank Davood Sabaghi (TUD), Dr. Markus Löffler (TUD), and Junjie Wang (TUD) for helpful discussions and characterizations. They also acknowledge the cfaed (Center for Advancing Electronics Dresden), the Dresden Center for Nanoanalysis (DCN), and High-Performance Computing Center (Nanjing Tech University). Yuping Wu appreciates the financial support from NSFC (Distinguished Youth Scientists Project of 51425301) and State Key Lab Research Foundation (ZK201805). H.S. thanks China Scholarship Council (CSC) for financial support. Open access funding enabled and organized by Projekt DEAL.

Conflict of interest

The authors declare no conflict of interest.

Keywords: etching · iodine · MXene · stability · two-dimensional materials

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Manuscript received: November 23, 2020

Revised manuscript received: January 18, 2021

Accepted manuscript online: January 22, 2021

Version of record online: March 10, 2021